

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/772,393	KIM, JIN-WON	
Examiner			Art Unit	2151	Page 1 of 1
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*	B US-2003/0012198	01-2003	Kaganoi et al.	370/392
*	C US-2004/0052263	03-2004	Xu, Haibo	370/399
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K	US-			
L	US-			
M	US-			

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**NON-PATENT DOCUMENTS**

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